

**Search Notes**

Application/Control No.

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Examiner

TUAN A. PHAM

Applicant(s)/Patent under  
Reexamination

KANEKO, ICHIRO

Art Unit

2618

**SEARCHED**

Class	Subclass	Date	Examiner
455	63.1	6/19/2006	PHAM
	67.11		
	67.13		
	67.15		
	70	6/19/2006	PHAM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with: Nguyen Vo	6/19/2006	PHAM